Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/737,196	RUFF, MATTHIAS	
Examiner	Art Unit	
Khanh V. Nguyen	2817	

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	DATE	EXMR
330/10,84,85,148,124R,295; 381/120,121 + Keywords	9/21/2006	NKV
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